•	Application No.	. Applicant(s)
Notice of Allowability	10/647,378	YONAGA ET AL.
	Examiner	Art Unit
	Christine T. Tu	2138
The MAILING DATE of this communication apper All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RI of the Office or upon petition by the applicant. See 37 CFR 1.313	(OR REMAINS) CLOSED in or other appropriate communication is separation in second control of the communication is second control of the cont	n this application. If not included unication will be mailed in due course. THIS
1. This communication is responsive to		
2. ☑ The allowed claim(s) is/are <u>1-5</u> .		
 3. Acknowledgment is made of a claim for foreign priority unally all blocks and blocks and blocks are considered as a claim for foreign priority unally all blocks are considered as a claim for foreign priority unall blocks. 1. Certified copies of the priority documents have a copies of the certified copies of the priority documents. 3. Copies of the certified copies of the priority documents. 	been received. been received in Applicatio	n No
International Bureau (PCT Rule 17.2(a)).	cuments have been received	in this national stage application from the
* Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	ENT of this application.	
4. A SUBSTITUTE OATH OR DECLARATION must be subminFORMAL PATENT APPLICATION (PTO-152) which give	itted. Note the attached EXA es reason(s) why the oath or	MINER'S AMENDMENT or NOTICE OF declaration is deficient.
5. CORRECTED DRAWINGS (as "replacement sheets") mus	t be submitted.	
(a) ☐ including changes required by the Notice of Draftspers	on's Patent Drawing Review	v (PTO-948) attached
1) ☐ hereto or 2) ☐ to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Paper No./Mail Date	s Amendment / Comment or	in the Office action of
ldentifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in tl	84(c)) should be written on the ne header according to 37 CF	e drawings in the front (not the back) of R 1.121(d).
6. DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT is	sit of BIOLOGICAL MATE FOR THE DEPOSIT OF BIO	ERIAL must be submitted. Note the DLOGICAL MATERIAL.
Attachment(s)	<u>_</u> .	
1. Notice of References Cited (PTO-892)		formal Patent Application (PTO-152)
2. Notice of Draftperson's Patent Drawing Review (PTO-948)	6. ∐ Interview St Paper No./l	ımmary (PTO-413), Mail Date
 Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date <u>Dec. 1, 2003</u> 	8), 7. 🛛 Examiner's	Mail Date Amendment/Comment
Examiner's Comment Regarding Requirement for Deposit of Biological Material	8. 🛛 Examiner's	Statement of Reasons for Allowance
· · · · · · · · · · · · · · · · · · ·	9. Other	Christone T. Tu
		Primary Examiner

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EXAMINER'S AMENDMENT

1. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.

The application has been amended as follows:

Claim 1:

At line 12, delete the word "means".

Claim 3:

At line 13, delete the word "means".

Claim 4:

At line 2, delete the word "means".

At line 4, replace the word "means" with -circuit--.

Claim 5:

At line 12, delete the word "means".

At line 15, replace the word "circuit" with -memory--.

At line 15, replace the word "substrate" with -memory--.

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2. The following is an examiner's statement of reasons for allowance:

The present invention pertains a test circuit or a semiconductor memory. The prior arts, however, do not teach a test circuit or a semiconductor memory comprising a the combination of an input circuit inputting data to select at test mode relative to a circuit to be tested and outputting result of selection of the test mode in synchronization with a first clock, a pattern generation circuit, responding to result of selection of the test mode, generating a test pattern in synchronization with a second clock and outputting the test pattern to a circuit to be tested; a comparator inputting results of test of the circuit to be tested in synchronization with the second clock, and comparing coincidence or non-coincidence between the result of the test and the test pattern supplied to the circuit to be tested, and an output circuit holding result of comparison by the comparator and outputting the result of comparison in synchronization with the first clock.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Christine T. Tu whose telephone number is (571)272-3831. The examiner can normally be reached on Mon-Thur. 8:30am-6:00pm.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Albert DeCady can be reached on (571)272-3819. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Christine T. Tu Primary Examiner Art Unit 2138

November 29, 2005